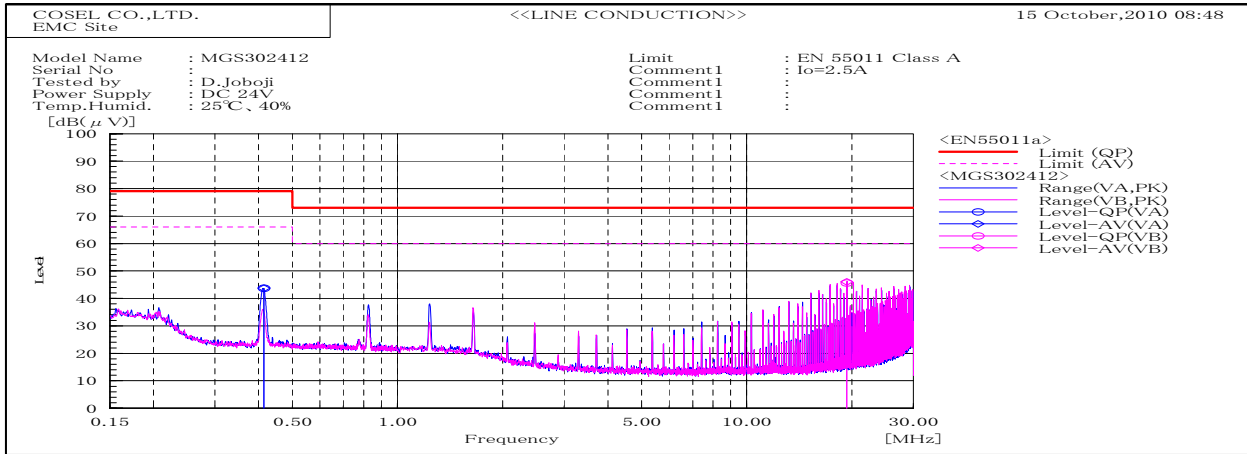
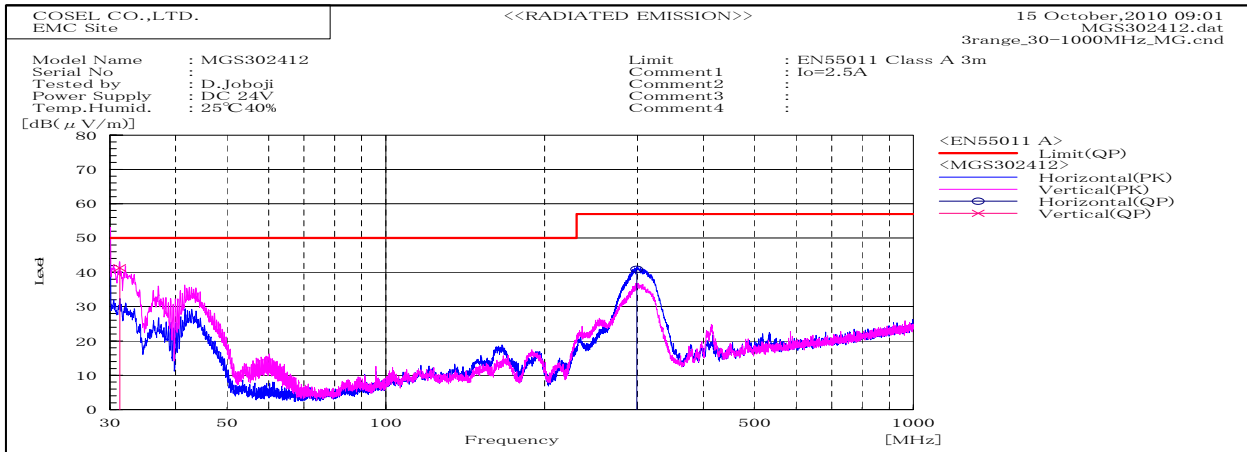


<b>DATA SHEET</b>		Date	19-Oct-10
Model	MGS302412	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	D.Joboji



Frequency MHz	Harm	Line Phase	Reading dB(μV)		Factor dB	Level dB(μV)		Limit dB(μV)		Margin dB		Pass/Fail	Remark
			QP	AV		QP	AV	QP	AV	QP	AV		
0.41434		VA	33.6	33.6	10.1	43.7	43.7	79	66	35.3	22.3	Pass	
19.3666		VB	34.6	35	11	45.6	46	73	60	27.4	14	Pass	

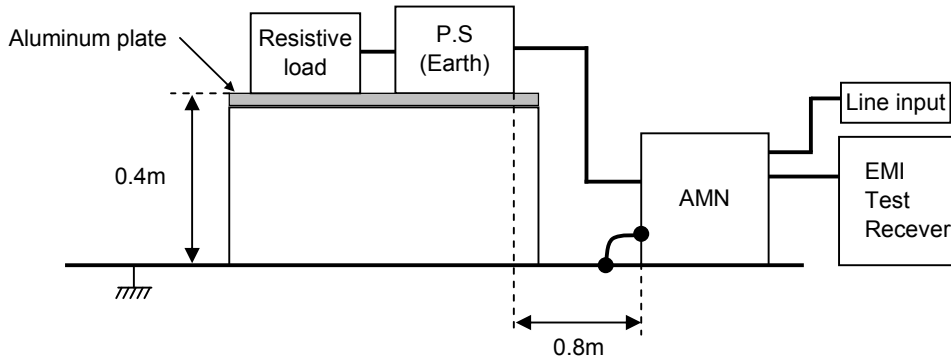


Frequency MHz	Polarization	Stability	Reading dB(μV)		Space Loss dB	Level dB(mW)		Limit dB(mW)	Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP			QP	QP						
31.331	V	Stable	55.4	-14.1		41.3	50	8.7	Pass	103	313		
299.143	H	Stable	58.5	-17.6		40.9	57	16.1	Pass	139	20		

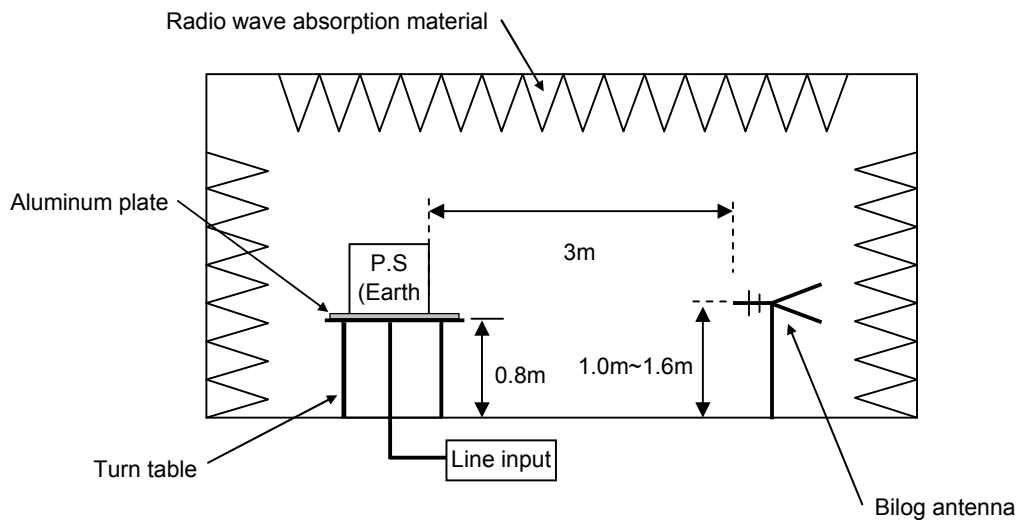
**DATA SHEET**

Model	Circuit used for measurement
Test	EMI Line conduction & Radiated emission

**1. Line conduction**



**2. Radiated emission**



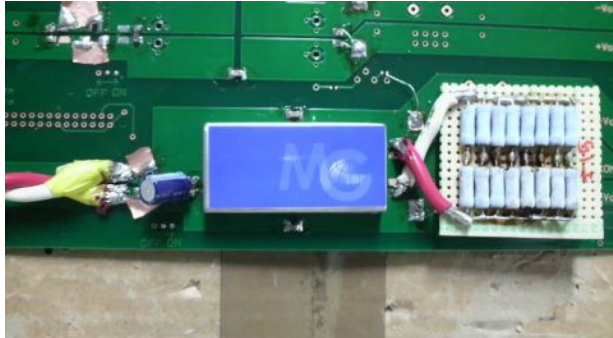


Conditions

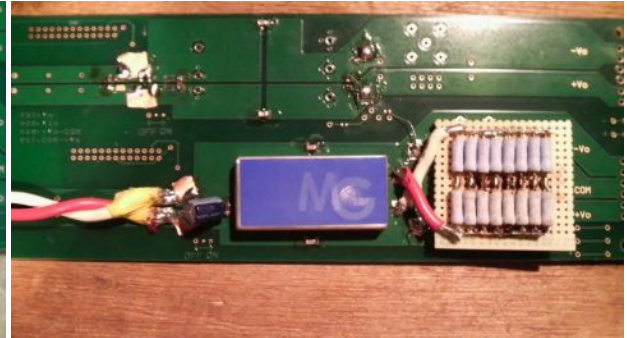
Test : EMI  
 Model Name : MGS3024□□/MGW3024□□

○Photographs of Test Set-Up

LINE CONDUCTION



RADIATED EMISSION



○Testing circuitry

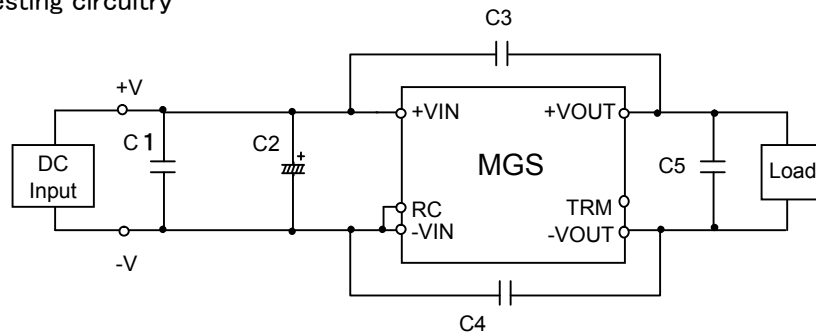


Fig.1 Testing circuitry 1

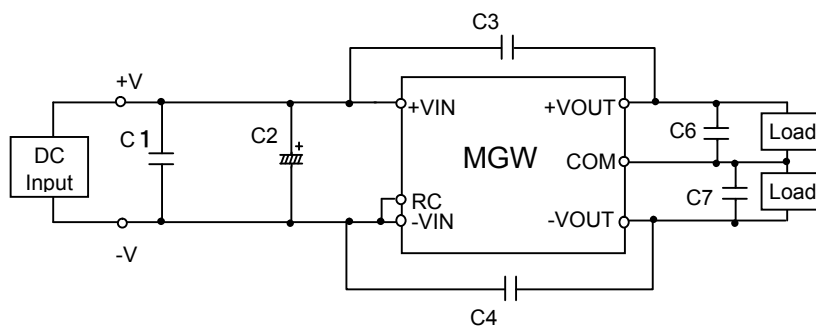


Fig.2 Testing circuitry 2

C1	:	50V	4.7 $\mu$ F	Ceramic Capacitor
C2	:	50V	100 $\mu$ F	Electrolytic Capacitor
C3,C4	:	2kV	1000pF	Ceramic Capacitor
C5,C6,C7	:	25V	22 $\mu$ F	Ceramic Capacitor